Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/797,008	OKAMOTO ET AL.	
Examiner	Art Unit	
Tianiie Chen	2656	

SEARCHED				
Class	Subclass	Date	Examiner	
Uadated		4/27/2006	TJ	
360	126	4/27/2006	7]	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR